NTD40N03R

Power MOSFET
40 Amps, 25 Volts

N-Channel DPAK

Features

- Planar HD3e Process for Fast Switching Performance
- Low $R_{DS(on)}$ to Minimize Conduction Loss
- Low C_{iss} to Minimize Driver Loss
- Low Gate Charge
- Optimized for High Side Switching Requirements in High-Efficiency DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	25	Vdc
Gate-to-Source Voltage - Continuous	V_{GS}	±20	Vdc
Thermal Resistance - Junction-to-Case Total Power Dissipation @ T_A = 25°C Drain Current - Continuous @ T_A = 25°C, Chip - Continuous @ T_A = 25°C, Limited by Wires - Single Pulse (tp ≤ 10 μs)	$R_{\theta JC}$ P_D I_D I_D I_D	3.0 41.7 40 32 80	°C/W W A A A
Thermal Resistance - Junction-to-Ambient (Note 1) Total Power Dissipation @ T_A = 25°C Drain Current - Continuous @ T_A = 25°C	$R_{\theta JA}$ P_D I_D	71.4 1.75 8.0	°C/W W A
Thermal Resistance - Junction-to-Ambient (Note 2) Total Power Dissipation @ T_A = 25°C Drain Current - Continuous @ T_A = 25°C	$R_{\theta JA}$ P_D I_D	100 1.25 7.0	°C/W W A
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to 150	°C
Maximum Lead Temperature for Soldering Purposes, 1/8″ from case for 10 seconds	T_L	260	°C

1. When surface mounted to an FR4 board using 0.5 sq in pad size.
2. When surface mounted to an FR4 board using minimum recommended pad size.

ON Semiconductor®

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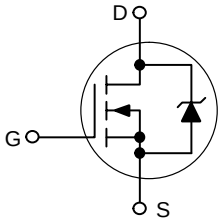
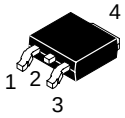
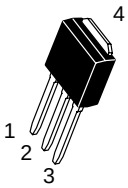
40 AMPERES, 25 VOLTS
$R_{DS(on)}$ = 12.6 mΩ (Typ)

N-CHANNEL



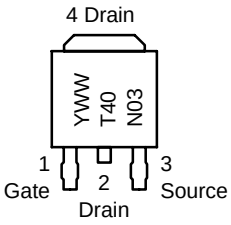


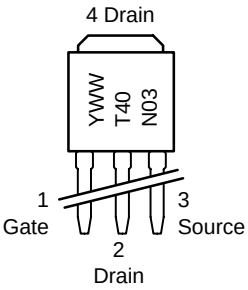
CASE 369C
DPAK
(Surface Mount)
STYLE 2



CASE 369D
DPAK
(Straight Lead)
STYLE 2

MARKING DIAGRAM
& PIN ASSIGNMENTS





40N03 = Device Code
Y = Year
WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping
NTD40N03R	DPAK	75 Units/Rail
NTD40N03R-1	DPAK Straight Lead	75 Units/Rail
NTD40N03RT4	DPAK	2500 Tape & Reel

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Characteristics	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Drain-to-Source Breakdown Voltage (Note 3) (V_{GS} = 0 Vdc, I_D = 250 μAdc) Temperature Coefficient (Positive)	$V(br)_{DSS}$	 25 -	 28 -	 - -	Vdc mV/°C
Zero Gate Voltage Drain Current (V_{DS} = 20 Vdc, V_{GS} = 0 Vdc) (V_{DS} = 20 Vdc, V_{GS} = 0 Vdc, T_J = 150°C)	I_{DSS}	 - -	 - -	 1.0 10	μAdc
Gate-Body Leakage Current (V_{GS} = ±20 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	-	-	±100	nAdc
ON CHARACTERISTICS (Note 3)					
Gate Threshold Voltage (Note 3) (V_{DS} = V_{GS}, I_D = 250 μAdc) Threshold Temperature Coefficient (Negative)	$V_{GS(th)}$	 1.0 -	 1.7 -	 2.0 -	Vdc mV/°C
Static Drain-to-Source On-Resistance (Note 3) (V_{GS} = 4.5 Vdc, I_D = 10 Adc) (V_{GS} = 10 Vdc, I_D = 10 Adc)	$R_{DS(on)}$	 - -	 18.6 12.6	 23 16.5	mΩ
Forward Transconductance (Note 3) (V_{DS} = 10 Vdc, I_D = 10 Adc)	g_{FS}	 -	 20	 -	Mhos
DYNAMIC CHARACTERISTICS					
Input Capacitance	(V_{DS} = 20 Vdc, V_{GS} = 0 V, f = 1 MHz)	C_{iss}	-	584	-	pF
Output Capacitance		C_{oss}	-	254	-	
Transfer Capacitance		C_{rss}	-	99	-	
SWITCHING CHARACTERISTICS (Note 4)					
Turn-On Delay Time	(V_{GS} = 10 Vdc, V_{DD} = 10 Vdc, I_D = 10 Adc, R_G = 3 Ω)	$t_{d(on)}$	-	4.5	-	ns
Rise Time		t_r	-	19.5	-	
Turn-Off Delay Time		$t_{d(off)}$	-	16.7	-	
Fall Time		t_f	-	3.5	-	
Gate Charge	(V_{GS} = 4.5 Vdc, I_D = 10 Adc, V_{DS} = 10 Vdc) (Note 3)	Q_T	-	5.78	-	nC
		Q_1	-	2.1	-	
		Q_2	-	2.5	-	
SOURCE-DRAIN DIODE CHARACTERISTICS					
Forward On-Voltage	(I_S = 10 Adc, V_{GS} = 0 Vdc) (Note 3) (I_S = 10 Adc, V_{GS} = 0 Vdc, T_J = 125°C)	V_{SD}	 - -	 0.85 0.71	 1.2 -	V_{dc}
Reverse Recovery Time	(I_S = 10 Adc, V_{GS} = 0 Vdc, dI_S/dt = 100 A/μs) (Note 3)	t_{rr}	-	20.4	-	ns
		t_a	-	8.25	-	
		t_b	-	12.1	-	
Reverse Recovery Stored Charge		Q_{RR}	-	0.007	-	μC

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

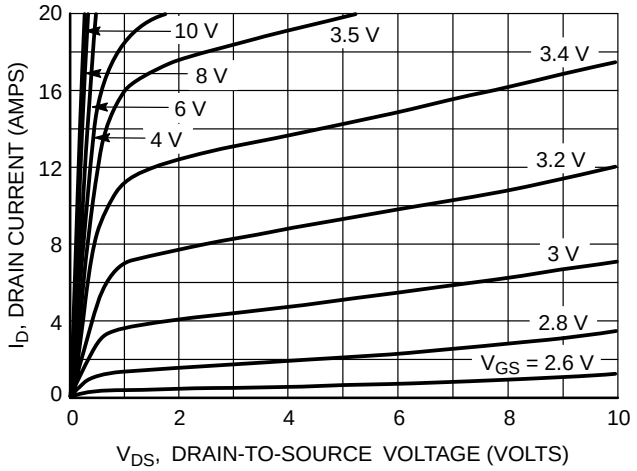


Figure 1. On-Region Characteristics

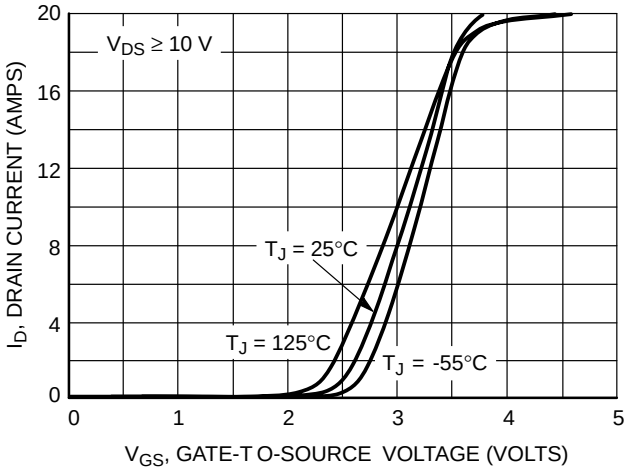


Figure 2. Transfer Characteristics

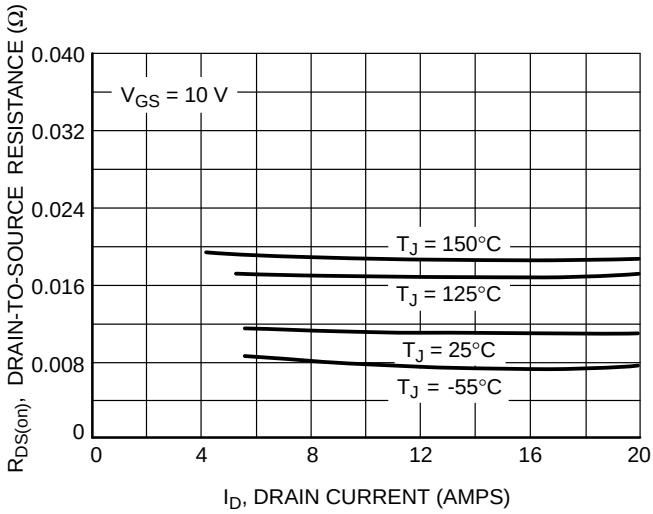


Figure 3. On-Resistance versus Drain Current and Temperature

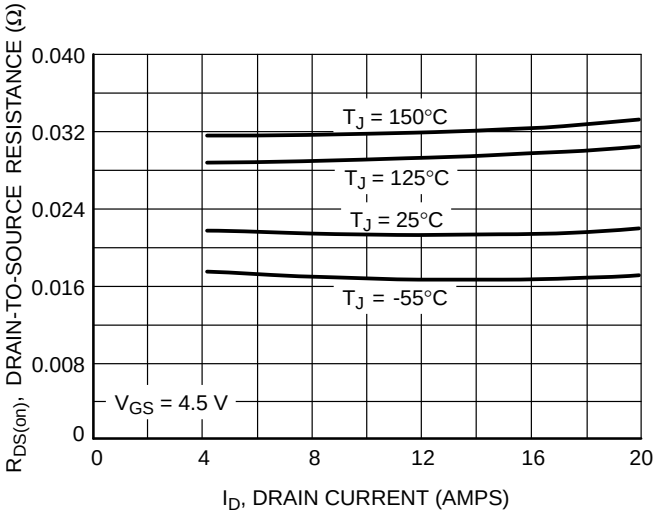


Figure 4. On-Resistance versus Drain Current and Temperature

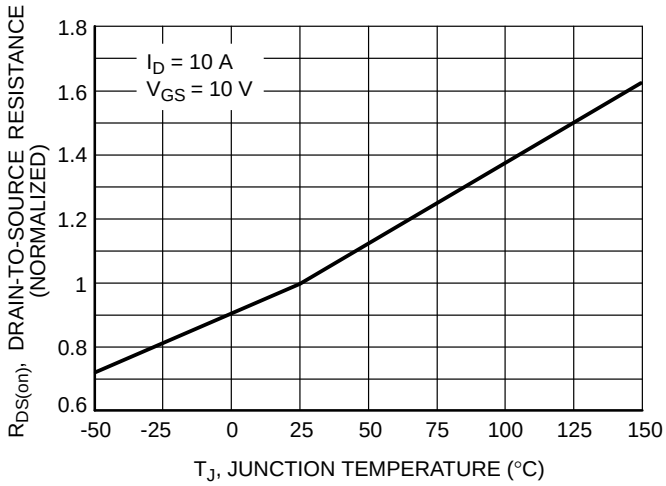


Figure 5. On-Resistance Variation with Temperature

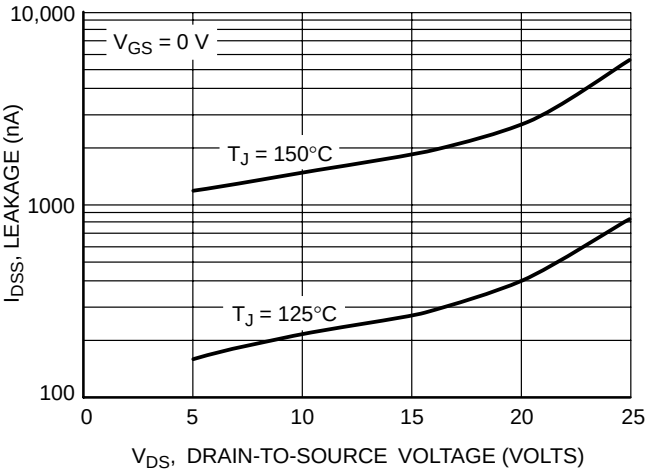


Figure 6. Drain-to-Source Leakage Current versus Voltage

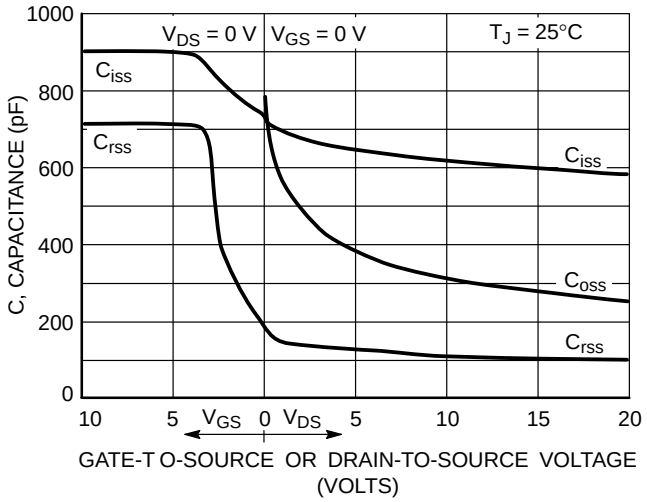


Figure 7. Capacitance Variation

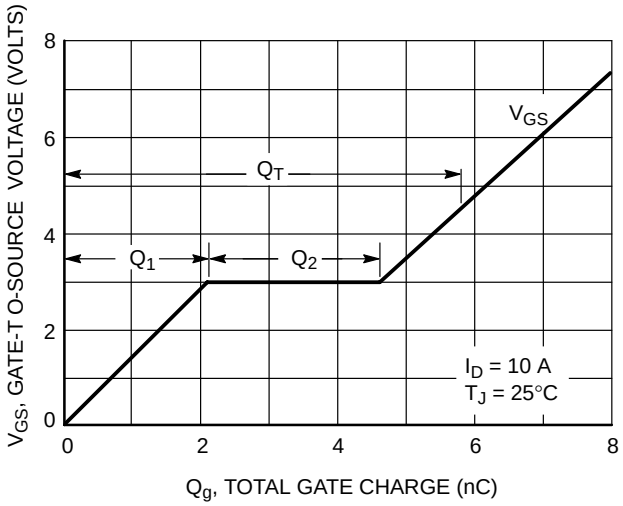


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

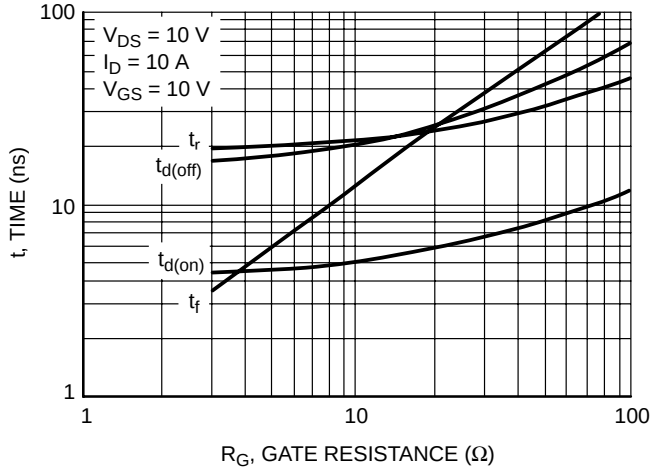


Figure 9. Resistive Switching Time Variation versus Gate Resistance

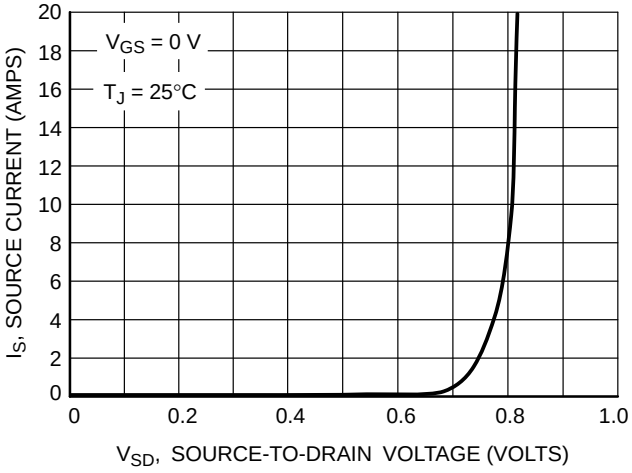


Figure 10. Diode Forward Voltage versus Current

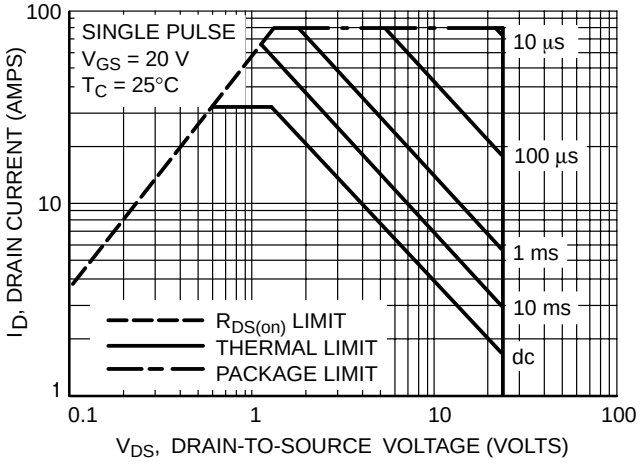


Figure 11. Maximum Rated Forward Biased Safe Operating Area

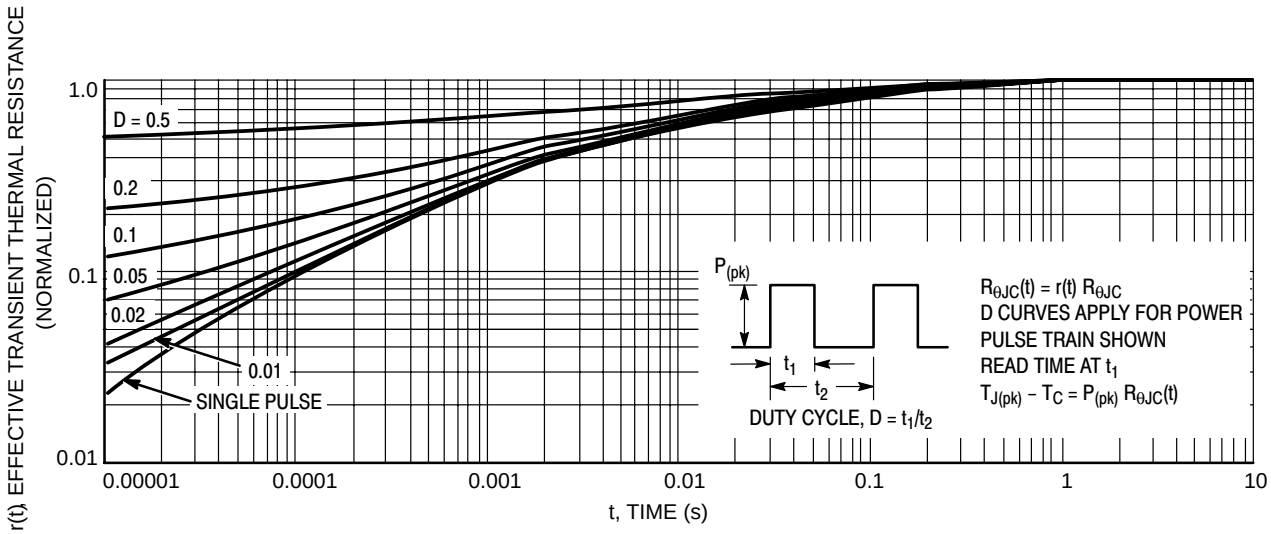
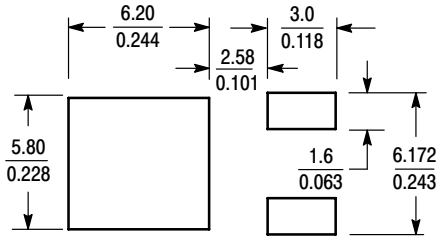


Figure 12. Thermal Response

RECOMMENDED FOOTPRINTS FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to ensure proper solder connection interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



POWER DISSIPATION FOR A SURFACE MOUNT DEVICE

The power dissipation for a surface mount device is a function of the drain/collector pad size. These can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating ambient temperature, T_A. Using the values provided on the data sheet, P_D can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of 25°C, one can calculate the power dissipation of the device. For a DPAK device, P_D is calculated as follows.

$$P_D = \frac{150°C - 25°C}{71.4°C/W} = 1.75 \text{ Watts}$$

The 71.4°C/W for the DPAK package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 1.75 Watts. There are other alternatives to achieving higher power dissipation from the surface mount packages. One is to increase the area of the drain pad. By increasing the area of the drain pad, the power dissipation can be increased. Although one can almost double the power dissipation with this method, one will be giving up area on the printed circuit board which can defeat the purpose of using surface mount technology. For example, a graph of $R_{\theta JA}$ versus drain pad area is shown in Figure 13.

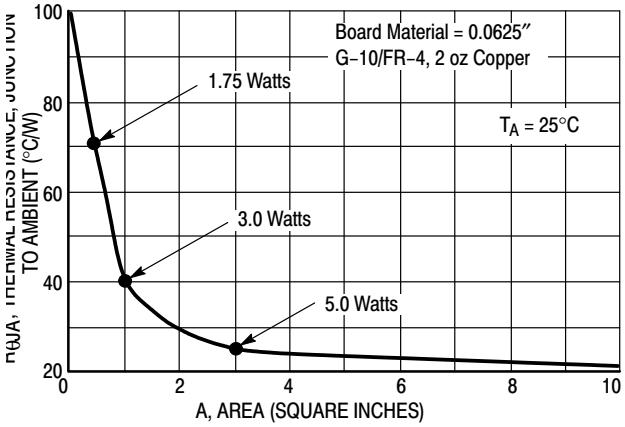
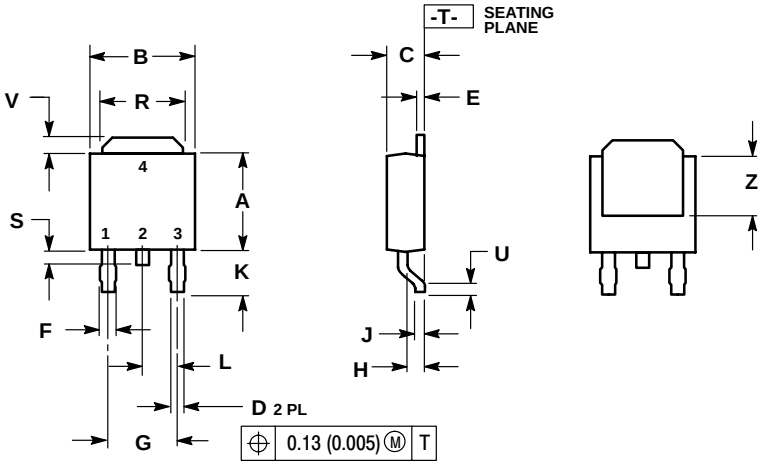


Figure 13. Thermal Resistance versus Drain Pad Area for the DPAK Package (Typical)

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)
CASE 369C
ISSUE O



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

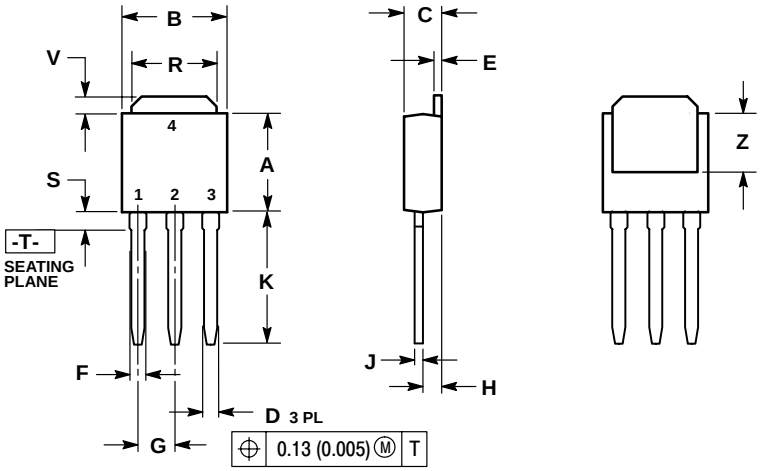
	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.22
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020	---	0.51	---
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

STYLE 2:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)
CASE 369D
ISSUE O

SCALE 1:1



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E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

STYLE 2:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

PUBLICATION ORDERING INFORMATION

Literature Fulfillment:
Literature Distribution Center for ON Semiconductor
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Email: ONlit@hibbertco.com

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2-9-1 Kamimeguro, Meguro-ku, Tokyo, Japan 153-0051
Phone: 81-3-5773-3850

ON Semiconductor Website: http://onsemi.com

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NTD40N03R/D